

DATA SHEET

74HC2G86; 74HCT2G86
Dual 2-input exclusive-OR gate

Product specification
Supersedes data of 2002 Jul 17

2003 Jul 28

Dual 2-input exclusive-OR gate**74HC2G86; 74HCT2G86****FEATURES**

- Wide supply voltage range from 2.0 to 6.0 V
- Symmetrical output impedance
- High noise immunity
- Low power dissipation
- Balanced propagation delays
- Very small 8 pins package
- ESD protection:
HBM EIA/JESD22-A114-A exceeds 2000 V
MM EIA/JESD22-A115-A exceeds 200 V.

DESCRIPTION

The 74HC2G/HCT2G86 is a high-speed Si-gate CMOS device.

The 74HC2G/HCT2G86 provides dual 2-input exclusive-OR gate.

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25^{\circ}\text{C}$; $t_r = t_f \leq 6.0 \text{ ns}$.

| SYMBOL | PARAMETER | CONDITIONS | TYPICAL | | UNIT |
|-------------------|--|---|---------|---------|------|
| | | | HC2G86 | HCT2G86 | |
| t_{PHL}/t_{PLH} | propagation delay nA to nY | $C_L = 50 \text{ pF}; V_{CC} = 4.5 \text{ V}$ | 11 | 11 | ns |
| C_I | input capacitance | | 1.5 | 1.5 | pF |
| C_{PD} | power dissipation capacitance per gate | notes 1 and 2 | 10 | 9 | pF |

Notes

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

V_{CC} = supply voltage in Volts;

N = total switching outputs;

$\sum (C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.

2. For 74HC2G86 the condition is $V_I = \text{GND}$ to V_{CC} .

For 74HCT2G86 the condition is $V_I = \text{GND}$ to $V_{CC} - 1.5 \text{ V}$.

Dual 2-input exclusive-OR gate

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FUNCTION TABLE

See note 1.

| INPUT | | OUTPUT |
|-------|----|--------|
| nA | nA | nY |
| L | L | L |
| L | H | H |
| H | L | H |
| H | H | L |

Note

1. H = HIGH voltage level;
L = LOW voltage level.

ORDERING INFORMATION

| TYPE NUMBER | PACKAGE | | | | | |
|-------------|-------------------|------|---------|----------|----------|---------|
| | TEMPERATURE RANGE | PINS | PACKAGE | MATERIAL | CODE | MARKING |
| 74HC2G86DP | -40 to +125 °C | 8 | TSSOP8 | plastic | SOT505-2 | H86 |
| 74HCT2G86DP | -40 to +125 °C | 8 | TSSOP8 | plastic | SOT505-2 | T86 |
| 74HC2G86DC | -40 to +125 °C | 8 | VSSOP8 | plastic | SOT765-1 | H86 |
| 74HCT2G86DC | -40 to +125 °C | 8 | VSSOP8 | plastic | SOT765-1 | H86 |

PINNING

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|----------------|
| 1 | 1A | data input 1A |
| 2 | 1B | data input 1B |
| 3 | 2Y | data output 2Y |
| 4 | GND | ground (0 V) |
| 5 | 2A | data input 2A |
| 6 | 2B | data input 2B |
| 7 | 1Y | data output 1Y |
| 8 | Vcc | supply voltage |

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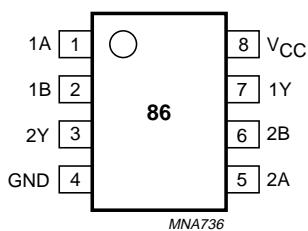


Fig.1 Pin configuration.

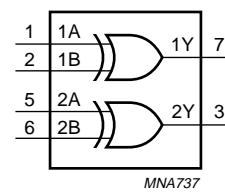


Fig.2 Logic symbol.

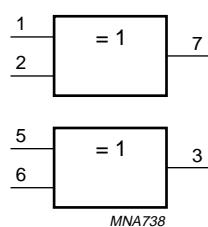


Fig.3 IEC logic symbol.

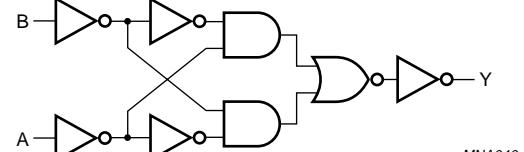


Fig.4 Logic diagram (one driver).

Dual 2-input exclusive-OR gate

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RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | CONDITIONS | 74HC2G86 | | | 74HCT2G86 | | | UNIT |
|---------------------------------|-------------------------------|--|----------|------|-----------------|-----------|------|-----------------|------|
| | | | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. | |
| V _{CC} | supply voltage | | 2.0 | 5.0 | 6.0 | 4.5 | 5.0 | 5.5 | V |
| V _I | input voltage | | 0 | – | V _{CC} | 0 | – | V _{CC} | V |
| V _O | output voltage | | 0 | – | V _{CC} | 0 | – | V _{CC} | V |
| T _{amb} | operating ambient temperature | see DC and AC characteristics per device | –40 | +25 | +125 | –40 | +25 | +125 | °C |
| t _r , t _f | input rise and fall times | V _{CC} = 2.0 V | – | – | 1000 | – | – | – | ns |
| | | V _{CC} = 4.5 V | – | 6.0 | 500 | – | 6.0 | 500 | ns |
| | | V _{CC} = 6.0 V | – | – | 400 | – | – | – | ns |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|--------------------------------|---|------|------|------|
| V _{CC} | supply voltage | | –0.5 | +7.0 | V |
| I _{IK} | input diode current | V _I < –0.5 V or V _I > V _{CC} + 0.5 V; note 1 | – | ±20 | mA |
| I _{OK} | output diode current | V _O < –0.5 V or V _O > V _{CC} + 0.5 V; note 1 | – | ±20 | mA |
| I _O | output source or sink current | –0.5 V < V _O < V _{CC} + 0.5 V; note 1 | – | 25 | mA |
| I _{CC} | V _{CC} or GND current | note 1 | – | 50 | mA |
| T _{stg} | storage temperature | | –65 | +150 | °C |
| P _D | power dissipation | T _{amb} = –40 to +125 °C; note 2 | – | 300 | mW |

Notes

1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. Above 110 °C the value of P_D derates linearly with 8 mW/K.

Dual 2-input exclusive-OR gate

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DC CHARACTERISTICS

Type 74HC2G86

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|--------------------------------|---------------------------|---|---------------------|------|------|------|------|
| | | OTHER | V _{CC} (V) | | | | |
| T_{amb} = 25 °C | | | | | | | |
| V _{IH} | HIGH-level input voltage | | 2.0 | 1.5 | 1.2 | – | V |
| | | | 4.5 | 3.15 | 2.4 | – | V |
| | | | 6.0 | 4.2 | 3.2 | – | V |
| V _{IL} | LOW-level input voltage | | 2.0 | – | 0.8 | 0.5 | V |
| | | | 4.5 | – | 2.1 | 1.35 | V |
| | | | 6.0 | – | 2.8 | 1.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} | | | | | |
| | | I _O = –20 µA | 2.0 | 1.9 | 2.0 | – | V |
| | | I _O = –20 µA | 4.5 | 4.4 | 4.5 | – | V |
| | | I _O = –20 µA | 6.0 | 5.9 | 6.0 | – | V |
| | | I _O = –4.0 mA | 4.5 | 4.18 | 4.32 | – | V |
| | | I _O = –5.2 mA | 6.0 | 5.68 | 5.81 | – | V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} | | | | | |
| | | I _O = 20 µA | 2.0 | – | 0 | 0.1 | V |
| | | I _O = 20 µA | 4.5 | – | 0 | 0.1 | V |
| | | I _O = 20 µA | 6.0 | – | 0 | 0.1 | V |
| | | I _O = 4.0 mA | 4.5 | – | 0.15 | 0.26 | V |
| I _{LI} | input leakage current | V _I = V _{CC} or GND | 6.0 | – | – | ±0.1 | µA |
| | | V _I = V _{CC} or GND; I _O = 0 | 6.0 | – | – | 1.0 | µA |

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| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|--|---------------------------|--|---------------------|------|------|------|------|
| | | OTHER | V _{CC} (V) | | | | |
| T_{amb} = -40 to +85 °C | | | | | | | |
| V _{IH} | HIGH-level input voltage | | 2.0 | 1.5 | — | — | V |
| | | | 4.5 | 3.15 | — | — | V |
| | | | 6.0 | 4.2 | — | — | V |
| V _{IL} | LOW-level input voltage | | 2.0 | — | — | 0.5 | V |
| | | | 4.5 | — | — | 1.35 | V |
| | | | 6.0 | — | — | 1.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} | | | | | |
| | | I _O = -20 µA | 2.0 | 1.9 | — | — | V |
| | | I _O = -20 µA | 4.5 | 4.4 | — | — | V |
| | | I _O = -20 µA | 6.0 | 5.9 | — | — | V |
| | | I _O = -4.0 mA | 4.5 | 4.13 | — | — | V |
| | | I _O = -5.2 mA | 6.0 | 5.63 | — | — | V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} | | | | | |
| | | I _O = 20 µA | 2.0 | — | — | 0.1 | V |
| | | I _O = 20 µA | 4.5 | — | — | 0.1 | V |
| | | I _O = 20 µA | 6.0 | — | — | 0.1 | V |
| | | I _O = 4.0 mA | 4.5 | — | — | 0.33 | V |
| I _{LI} | input leakage current | V _I = V _{CC} or GND | 6.0 | — | — | ±1.0 | µA |
| | | | | | | | |
| I _{CC} | quiescent supply current | V _I = V _{CC} or GND; I _O = 0 | 6.0 | — | — | 10 | µA |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|---------------------------|---|---------------------|------|------|------|------|
| | | OTHER | V _{CC} (V) | | | | |
| T_{amb} = -40 to +125 °C | | | | | | | |
| V _{IH} | HIGH-level input voltage | | 2.0 | 1.5 | — | — | V |
| | | | 4.5 | 3.15 | — | — | V |
| | | | 6.0 | 4.2 | — | — | V |
| V _{IL} | LOW-level input voltage | | 2.0 | — | — | 0.5 | V |
| | | | 4.5 | — | — | 1.35 | V |
| | | | 6.0 | — | — | 1.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} | | | | | |
| | | I _O = -20 µA | 2.0 | 1.9 | — | — | V |
| | | I _O = -20 µA | 4.5 | 4.4 | — | — | V |
| | | I _O = -20 µA | 6.0 | 5.9 | — | — | V |
| | | I _O = -4.0 mA | 4.5 | 3.7 | — | — | V |
| | | I _O = -5.2 mA | 6.0 | 5.2 | — | — | V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} | | | | | |
| | | I _O = 20 µA | 2.0 | — | — | 0.1 | V |
| | | I _O = 20 µA | 4.5 | — | — | 0.1 | V |
| | | I _O = 20 µA | 6.0 | — | — | 0.1 | V |
| | | I _O = 4.0 mA | 4.5 | — | — | 0.4 | V |
| I _{LI} | input leakage current | V _I = V _{CC} or GND | 6.0 | — | — | ±1.0 | µA |
| | | V _I = V _{CC} or GND; I _O = 0 | 6.0 | — | — | 20 | µA |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

Type 74HCT2G86

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|--|-------------------------------------|--|---------------------|-------------|-------------|-------------|--------|
| | | OTHER | V _{CC} (V) | | | | |
| T_{amb} = 25 °C | | | | | | | |
| V _{IH} | HIGH-level input voltage | | 4.5 to 5.5 | 2.0 | 1.6 | – | V |
| V _{IL} | LOW-level input voltage | | 4.5 to 5.5 | – | 1.2 | 0.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} I _O = –20 µA I _O = –4.0 mA | 4.5 4.5 | 4.4 4.18 | 4.5 4.32 | – – | V V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} I _O = 20 µA I _O = 4.0 mA | 4.5 4.5 | – – | 0 0.15 | 0.1 0.26 | V V |
| I _{LI} | input leakage current | V _I = V _{CC} or GND | 5.5 | – | – | ±0.1 | µA |
| I _{CC} | quiescent supply current | V _I = V _{CC} or GND; I _O = 0 | 5.5 | – | – | 1.0 | µA |
| ΔI _{CC} | additional supply current per input | V _I = V _{CC} – 2.1 V; I _O = 0 | 4.5 to 5.5 | – | – | 300 | µA |
| T_{amb} = –40 to +85 °C | | | | | | | |
| V _{IH} | HIGH-level input voltage | | 4.5 to 5.5 | 2.0 | – | – | V |
| V _{IL} | LOW-level input voltage | | 4.5 to 5.5 | – | – | 0.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} I _O = –20 µA I _O = –4.0 mA | 4.5 4.5 | 4.4 4.13 | – – | – – | V V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} I _O = 20 µA I _O = 4.0 mA | 4.5 4.5 | – – | – – | 0.1 0.33 | V V |
| I _{LI} | input leakage current | V _I = V _{CC} or GND | 5.5 | – | – | ±1.0 | µA |
| I _{CC} | quiescent supply current | V _I = V _{CC} or GND; I _O = 0 | 5.5 | – | – | 10 | µA |
| ΔI _{CC} | additional supply current per input | V _I = V _{CC} – 2.1 V; I _O = 0 | 4.5 to 5.5 | – | – | 375 | µA |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|-------------------------------------|--|---------------------|------------|--------|------------|--------|
| | | OTHER | V _{CC} (V) | | | | |
| T_{amb} = -40 to +125 °C | | | | | | | |
| V _{IH} | HIGH-level input voltage | | 4.5 to 5.5 | 2.0 | — | — | V |
| V _{IL} | LOW-level input voltage | | 4.5 to 5.5 | — | — | 0.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} I _O = -20 µA I _O = -4.0 mA | 4.5 4.5 | 4.4 3.7 | — — | — — | V V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} I _O = 20 µA I _O = 4.0 mA | 4.5 4.5 | — — | — — | 0.1 0.4 | V V |
| I _{LI} | input leakage current | V _I = V _{CC} or GND | 5.5 | — | — | ±1.0 | µA |
| I _{CC} | quiescent supply current | V _I = V _{CC} or GND; I _O = 0 | 5.5 | — | — | 20 | µA |
| ΔI _{CC} | additional supply current per input | V _I = V _{CC} - 2.1 V; I _O = 0 | 4.5 to 5.5 | — | — | 410 | µA |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

AC CHARACTERISTICS

Type 74HC2G86

GND = 0 V; $t_r = t_f \leq 6.0$ ns; $C_L = 50$ pF.

| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|--|--------------------------------|------------------|--------------|------|------|------|------|
| | | WAVEFORMS | V_{CC} (V) | | | | |
| $T_{amb} = 25^\circ C$ | | | | | | | |
| t_{PHL}/t_{PLH} | propagation delay nA, nB to nY | see Figs 5 and 6 | 2.0 | — | 34 | 120 | ns |
| | | | 4.5 | — | 11 | 20 | ns |
| | | | 6.0 | — | 9 | 17 | ns |
| t_{THL}/t_{TLH} | output transition time | see Figs 5 and 6 | 2.0 | — | 18 | 75 | ns |
| | | | 4.5 | — | 6 | 15 | ns |
| | | | 6.0 | — | 5 | 13 | ns |
| $T_{amb} = -40$ to $+85^\circ C$ | | | | | | | |
| t_{PHL}/t_{PLH} | propagation delay nA, nB to nY | see Figs 5 and 6 | 2.0 | — | — | 150 | ns |
| | | | 4.5 | — | — | 25 | ns |
| | | | 6.0 | — | — | 21 | ns |
| t_{THL}/t_{TLH} | output transition time | see Figs 5 and 6 | 2.0 | — | — | 95 | ns |
| | | | 4.5 | — | — | 19 | ns |
| | | | 6.0 | — | — | 16 | ns |
| $T_{amb} = -40$ to $+125^\circ C$ | | | | | | | |
| t_{PHL}/t_{PLH} | propagation delay nA, nB to nY | see Figs 5 and 6 | 2.0 | — | — | 180 | ns |
| | | | 4.5 | — | — | 36 | ns |
| | | | 6.0 | — | — | 30 | ns |
| t_{THL}/t_{TLH} | output transition time | see Figs 5 and 6 | 2.0 | — | — | 110 | ns |
| | | | 4.5 | — | — | 22 | ns |
| | | | 6.0 | — | — | 20 | ns |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

Type 74HCT2G86GND = 0 V; $t_r = t_f \leq 6.0$ ns; $C_L = 50$ pF.

| SYMBOL | PARAMETER | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|--|--------------------------------|------------------|--------------|------|------|------|------|
| | | WAVEFORMS | V_{CC} (V) | | | | |
| $T_{amb} = 25^\circ C$ | | | | | | | |
| t_{PHL}/t_{PLH} | propagation delay nA, nB to nY | see Figs 5 and 6 | 4.5 | — | 11 | 19 | ns |
| t_{TLH}/t_{THL} | output transition time | see Figs 5 and 6 | 4.5 | — | 6 | 15 | ns |
| $T_{amb} = -40$ to $+85^\circ C$ | | | | | | | |
| t_{PHL}/t_{PLH} | propagation delay nA, nB to nY | see Figs 5 and 6 | 4.5 | — | — | 23 | ns |
| t_{TLH}/t_{THL} | output transition time | see Figs 5 and 6 | 4.5 | — | — | 19 | ns |
| $T_{amb} = -40$ to $+125^\circ C$ | | | | | | | |
| t_{PHL}/t_{PLH} | propagation delay nA, nB to nY | see Figs 5 and 6 | 4.5 | — | — | 48 | ns |
| t_{TLH}/t_{THL} | output transition time | see Figs 5 and 6 | 4.5 | — | — | 22 | ns |

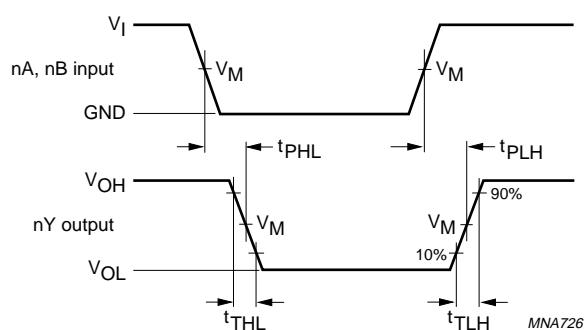
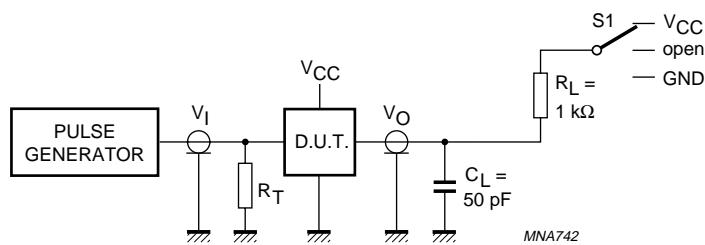
AC WAVEFORMSFor HC2G: $V_M = 50\%$; $V_I = \text{GND to } V_{CC}$.For HCT2G: $V_M = 1.3$ V; $V_I = \text{GND to } 3.0$ V.

Fig.5 The input (nA, nB) to output (nY) propagation delays.

Dual 2-input exclusive-OR gate

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| TEST | S1 |
|-------------------|----------|
| t_{PLH}/t_{PHL} | open |
| t_{PLZ}/t_{PZL} | V_{CC} |
| t_{PHZ}/t_{PZH} | GND |

Definitions for test circuit:

R_L = Load resistor.

C_L = Load capacitance including jig and probe capacitance.

R_T = Termination resistance should be equal to the output impedance Z_o of the pulse generator.

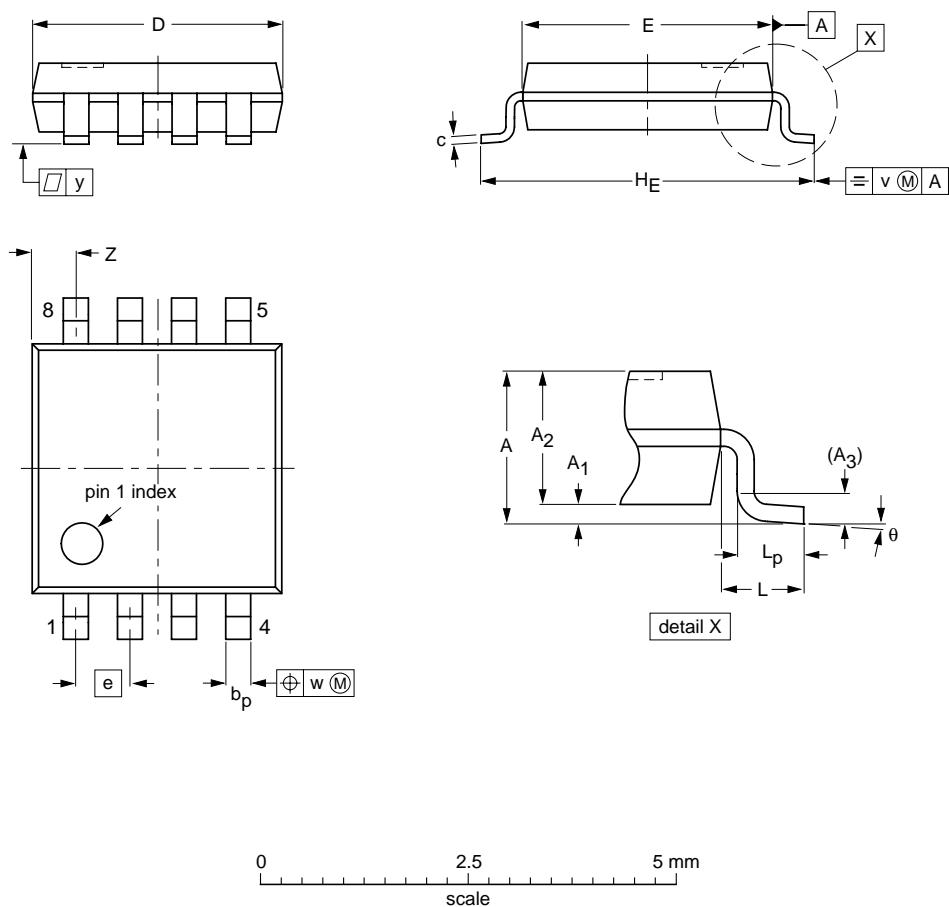
Fig.6 Load circuitry for switching times.

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

PACKAGE OUTLINES

TSSOP8: plastic thin shrink small outline package; 8 leads; body width 3 mm; lead length 0.5 mm SOT505-2



DIMENSIONS (mm are the original dimensions)

| UNIT | A max. | A ₁ | A ₂ | A ₃ | b _p | c | D ⁽¹⁾ | E ⁽¹⁾ | e | H _E | L | L _p | v | w | y | Z ⁽¹⁾ | θ |
|------|-------------|----------------|----------------|----------------|----------------|--------------|------------------|------------------|------|----------------|-----|----------------|-----|------|-----|------------------|----------|
| mm | 1.1 0.00 | 0.15 0.75 | 0.95 0.25 | 0.25 0.22 | 0.38 0.22 | 0.18 0.08 | 3.1 2.9 | 3.1 2.9 | 0.65 | 4.1 3.9 | 0.5 | 0.47 0.33 | 0.2 | 0.13 | 0.1 | 0.70 0.35 | 8° 0° |

Note

- Plastic or metal protrusions of 0.15 mm maximum per side are not included.

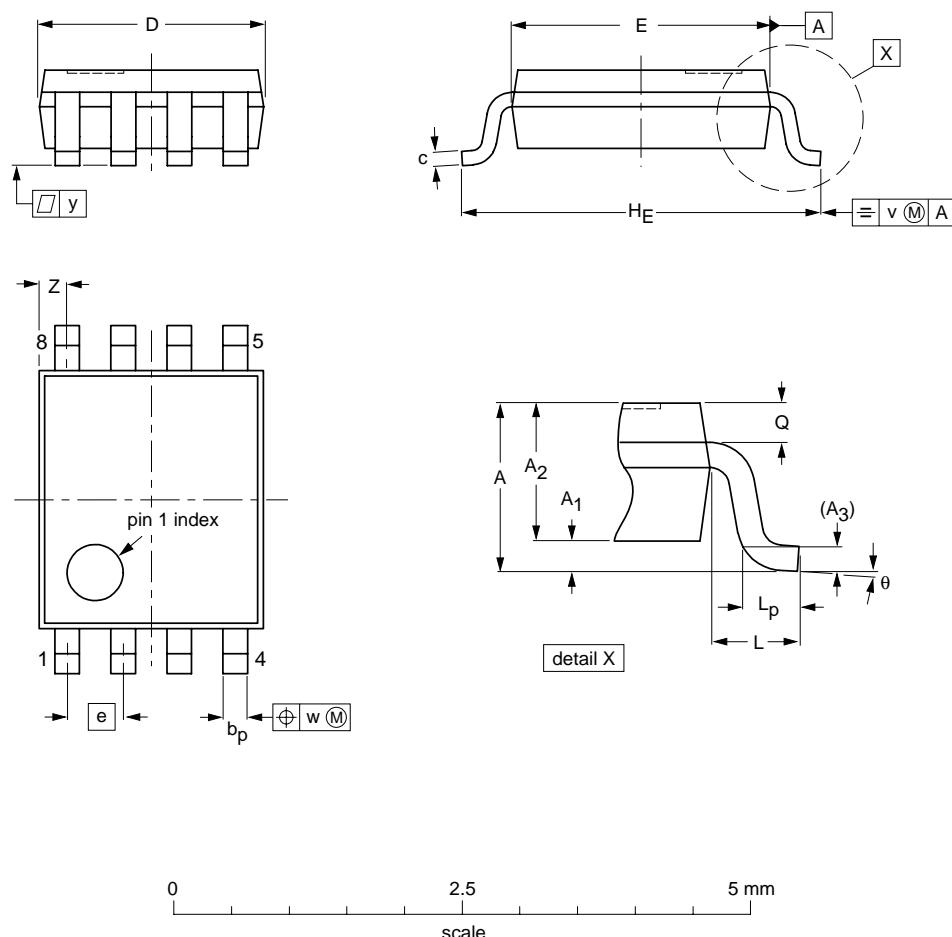
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|-------|--|------------------------|------------|
| | IEC | JEDEC | JEITA | | | |
| SOT505-2 | | --- | | | | 02-01-16 |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

VSSOP8: plastic very thin shrink small outline package; 8 leads; body width 2.3 mm

SOT765-1



DIMENSIONS (mm are the original dimensions)

| UNIT | A max. | A ₁ | A ₂ | A ₃ | b _p | c | D ⁽¹⁾ | E ⁽²⁾ | e | H _E | L | L _p | Q | v | w | y | Z ⁽¹⁾ | θ |
|------|-----------|----------------|----------------|----------------|----------------|--------------|------------------|------------------|-----|----------------|-----|----------------|--------------|-----|------|-----|------------------|----------|
| mm | 1 | 0.15 0.00 | 0.85 0.60 | 0.12 | 0.27 0.17 | 0.23 0.08 | 2.1 1.9 | 2.4 2.2 | 0.5 | 3.2 3.0 | 0.4 | 0.40 0.15 | 0.21 0.19 | 0.2 | 0.13 | 0.1 | 0.4 0.1 | 8° 0° |

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|--------|-------|--|------------------------|------------|
| | IEC | JEDEC | JEITA | | | |
| SOT765-1 | | MO-187 | | | | 02-06-07 |

Dual 2-input exclusive-OR gate

74HC2G86; 74HCT2G86

DATA SHEET STATUS

| LEVEL | DATA SHEET STATUS⁽¹⁾ | PRODUCT STATUS⁽²⁾⁽³⁾ | DEFINITION |
|--------------|--|--|--|
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